

Thyristor Surge Protector Product Change Notification PCN Tracking Number 37 - Chip Metallization Change

Recent advances in underbump metallization technology afford the opportunity for Bourns to change the wafer metallization system used on all SMA and SMB packaged products. Bourns wafers designed for solder die attach are manufactured with a multilayer metal system to achieve low contact resistance, high strength, good solderability and long application life. In the new system, the metallization deposition process will change from vacuum deposition only, to a combination of vacuum deposition and electroless plating. The deposition processes and thickness of each layer are shown in the table.

	Ċ	urrent	Füture		
	Deposition	Thickness	Deposition	Thickness	
Aluminum	Vacuum	6 microns	Vacuum	6 microns	
Titanium	Vacuum	0.15 microns	Not present	N/A	
Nickel	Vacuum	0.45 microns	Plating	2.0 - 5.0 microns	
Gold	Vacuum	0.04 microns	Plating	0.04 - 0.10 microns	

In vacuum metallizing, the titanium layer is necessary as an adhesive layer between nickel and aluminum. The nickel-plating process has high adhesion to aluminum so the titanium layer is no longer required.

Products Affected by the Change:

Initially, all overvoltage protection products assembled in the SMA and SMB are affected. Products with package code suffixes of AJ, AJR, BJ and BJR will be changed. For lead (Pb) free products, the corresponding codes are A -S, AJR-S, BJ-S and BJR-S. Products in other packages will be converted later.

Thyristor Surge Protector Product Change Notification PCN Tracking Number 37 - Chip Metallization Change Iulv. 2005 Page 2 of 4

Surface Mount Packages

TISP4xxxM3BJR

TISP43xxMMBJR

TISP4xxxH1BJR

TISP4xxxH3BJR

TISP4xxxH4BJR

TISP4AxxxH3BJR

TISP4CxxxxH3BJR

TISP5xxxH3BJR

TISP1xxxH3BJR

TISP3xxxT3BJR

Existing Part No	Package	Lead Free	RoHS Compliant	Lead Free Product Part Number Suffix -S or S	
TISP Products	•				
TISP4xxxL1AJR	SMA	Yes	Yes	TISP4xxxL1AJR-S	
TISP4xxxL3AJR	SMA	Yes	Yes	TISP4xxxL3AJR-S	
TISP4xxxM3AJR	SMA	Yes	Yes	TISP4xxxM3AJR-S	

TISP43xxMMAJR-S

TISP4xxxL1BJR-S

TISP4xxxL3BJR-S

TISP4xxxM3BJR-S

TISP43xxMMBJR-S

TISP4xxxH1BJR-S

TISP4xxxH3BJR-S

TISP4xxxH4BJR-S

TISP4AxxxH3BJRS

TISP4CxxxH3BJRS

TISP5xxxH3BJR-S

TISP1xxxH3BJR-S

TISP3xxxT3BJR-S

Yes

SMA TISP4xxxM3AJR

SMA

TISP43xxMMAJR **SMB** TISP4xxxL1BJR

TISP4xxxL3BJR

SMB

Yes Yes **SMB SMB**

Yes Yes Yes Yes SMB Yes

Yes SMB **SMB** Yes

Yes Yes

SMB SMB -SMB Yes SMB3 Yes SMB3 Yes

inventories of wafers manufactured prior to the change will be processed on a FIFO basis. From September 2005, onwards Bourns total shipments of SMA/SMB products will continue to contain

Reason for the Change: Recent advances in the development of underbump metal systems have indicated that plated me

layers are as reliable as the vacuum-deposited metallization systems currently used. **Product Labeling:**

There will be no change to the product labeling.

Identification of the Changed Product: Bourns maintains traceability back to source wafer lots for all products.

Implementation Date:

Manufacture of wafers with the changed metallization will begin in August 2005. Shipments of goods including the metallization changes are expected to commence in September 2005. Existing

wafers manufactured to the existing process until inventory is depleted.

Date Code Product will Include this Processing will be:

Impact on Form, Fit, Function and Reliability: None

Thyristor Surge Protector Product Change Notification PCN Tracking Number 37 - Chip Metallization Change July, 2005 Page 3 of 4

Qualification Plan:

See below.

Last Date of Manufacture of Unchanged Product:

July 2005

Point of Contact:



Quad Rep (M) Scin-Bhd 570C, 3rd Fir, Jin Sultan Azlan Shah, Sungai Nibong, 1900 Pulau Pinang, Malaysia. Tel: 604-66 1771 Fax: 604-6582771 http://www.quadrep.com

Qualification Information as Follows:

TJSP4XXXXH3BJ & TJSP4xxxxH3BJ	Chip Metallization Change
Die Technology	Thyristor Overvoltage Protector
Die Name	As Table (Row 2)
Die size (mil)	As Table (Row 3)
Top Metal	Al + NiAu
Back Metal	Al + NiAu .
Assembly Site	Shanghai Seefull Electronics Co, PRC
Pins/Package	SMB
Mold Compound	Sumitomo EME 1100H
Die Attach	Solder, Pb >85 %
Bond Wire	Solder Clip (3)
L/F Material	Copper
Marking	Laser
Termination Finish	Matte Sn (Pb Free)

hyristor Surge Protector Product Change Notification CN Tracking Number 37 Chip Metallization Change uly, 20**65** age 4 of 4

Qualification Samples Taken from Three Wafer Fabrication Lots:

				Mr. I.		' Test Plan		
tress less/condition (2)						Lot 1	Lot 2	Lot
	** OSS (1)	Standard	Method	SS/Accept	TW435PQ	TW435PQ	TA 230	
					94 x 81	94 x 81	65 x 65	
HTRB, 150 °C, 100 V, 100 0 h	009	101	MIL STD 883	1015	129/1	129	129	129
8 5 °C/85 %RH, 50 V, 100 0 h	009	102	JEDEC STD 22	A101	129/1	129	129	129
Temperature Cycle -								6
65/+150 °C, 200 cs	009	104	MIL STD 883	2031	129/1	129	129	129.
10/1000 μs Surge			GR-1089-CORE	-	16/0	16	16	16
2/10 μs Surge	-		GR-1089-CORE	_	16/0	16	16	16
Bond Strength, 300 g Min.								
(Note 4)	-		-	-	20/0	20/0	20/0	20/0

Notes:

- 1. QSS Specifications are Fourns Internal Qualification Standards.
- 2. Mechanical/Package Requirements qualified by similarity with existing product.
- 3. SMA and SMB packages are assembled by soldering the chip between a copper lead frame and copper clip.
- 4. Vertical Pull Test complete.

Stress Test Completion Date:

July 2005